

<b>INFORMATION DISCLOSURE CITATION</b>  <b>PTO-1449</b>			ATTY. DOCKET NO. 23444-712		SERIAL NO. 09/614,224		
			APPLICANT Thomas B. Mason et al.				
			FILING DATE 7/12/2000		GROUP <del>2874</del> 2828		
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE	
lj	5,088,105	2/11/92	Scifres et al.	372	92	/	
lj	5,479,539	12/26/95	Goldsmith et al.	385	14		
lj	5,525,541	6/11/96	Krauz et al.	437 438	161 28		
lj	5,625,636	4/29/97	Bryan et al.	372	50		
lj	5,674,778	10/7/97	Lee et al.	437 438	126 24		
lj	5,715,268	2/3/98	Lang et al.	372	50		
lj	5,742,045	4/21/98	Parker et al.	250	214A		
<b>FOREIGN PATENT DOCUMENTS</b>							
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
lj	0 620 475 A1	3/14/94	Europe	G02F	1/313	<input checked="" type="checkbox"/>	<input type="checkbox"/>
lj	1 539 028	1/24/79	Europe	Ho1S	3/02	<input checked="" type="checkbox"/>	<input type="checkbox"/>
<b>OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)</b>							
lj	Bar-Chaim, N. et al., "Monolithic Optoelectronic Integration of a GaAlAs Laser, a Field-Effect Transistor, and a Photodiode", <i>Applied Physics Letters, US, American Institute of Physics</i> , May 15, 1984, Vol. 44, No. 10, pp. 941-943						
	Koch, T.L., "Semiconductor Photonic Integrated Circuits", <i>IEEE Journal of Quantum Electronics</i> , Mar. 27, 1991, No. 3, pp. 641-653						
lj	Byoung-Sung, K. et al., "Dynamic Analysis of Widely Tunable Laser Diodes Integrated with Sampled-and-Chirped-Grating Distributed Bragg Reflectors and an Electroabsorption Modulator", <i>IEICE Trans Electron</i> , August 1998, Vol. E81-C, No. 8, pp. 1342-1349						
	San-Liang, L. et al., "Sampled Grating DBR Laser Arrays with Adjustable 0.8/1.6-nm Wavelength Spacing", <i>IEEE Photonics Technology Letters</i> , August 1999, Vol. 11, No. 8, pp. 955-957						
lj	Jayaraman, V. et al., "Theory, Design, and Performance of Extended Tuning Range Semiconductor Lasers with Sampled Gratings", <i>IEEE Journal of Quantum Electronics</i> , June 29, 1993, Vol. 29, No. 6, pp. 1824-1834						
/							
EXAMINER <u>Jeffrey Zahn</u>			DATE CONSIDERED <u>9/26/02</u>				

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.